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## » Key

IEEE JNL IEEE Journal or Magazine

IEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

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IEE JNL IEE Journal or Magazine

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DL Sniderman, JP Card, C Klimasauskas - [neumath.com](#)  
 ... For continuously **varying** and controlled variables (ConV and CV ... step function of  
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... but might serve to reduce computational **time** if the ... with respect to a property called **metric** topology preservation ... Randall S. Collica, **Jill P. Card**, and William ...  
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SHI Lin-Chu, W Shou-Jue, C Yong-Mei, W Xiang-Dong ... - 自动化学报, 2001 - 万方数据资源系统  
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... **process** is similar to the fast **Fourier** transform (FFT ... The polyphase matrix for the **wavelet** transform is ... then be computed by subtracting the **predicted** value from ...  
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JS Scholl, LP Clare, JR Agre - Meeting of IRIS Specialty Group on Acoustic and Seismic ... - janet.ucla.edu  
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... Define a crude **measure** of blocking artifact as the ... versions of the 4/4 spline **wavelet** filters: and ... Handling for Finite-Length Signals To **process** finite-length ...  
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W Applications - hybrid.iam.metu.edu.tr  
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**Wavelet Transform for Structural Health Monitoring: A Compendium of Uses and Features**

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... is analogous to frequency in **Fourier** analysis [23,29 ... of the scaling and the **wavelet** functions, respectively ... mentioning that a down-sampling **process** is performed ...  
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... modeling in combination with the **wavelet** decomposition can be ... sequence are compared using a **process** similar to ... 112] presented an objective **measurement** tool for ...  
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RJM II, Z Zhu - IEEE Signal Processing Magazine, 1995 - erc.msstate.edu  
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... of the signal and of **Fourier** spectral coefficients ... where the are the **wavelet** coefficients, is the ... on a Euclidean distance **measure** between **predicted** and observed ...

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Z Tan, T Hwang - Proceedings of SPIE, 1992 - [spie.org](#)

... 374, Automatic vision programs from **predicted** features Mulgaonkar ... is to describe and relate traditional **Fourier** methods to **wavelet**, **wavelet-packet** based ...

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| 14 | BRS  | L14 | 126  | (time-varying) and (target same metric)  | US-PGPUB;<br>USPAT;<br>USOCR;<br>FPRS;<br>EPO; JPO;<br>DERWEN<br>T;<br>IBM_TDB | 2006/09/13 17:29 |
| 15 | BRS  | L15 | 51   | (time-varying) and (target same metric same process)   | US-PGPUB;<br>USPAT;<br>USOCR;<br>FPRS;<br>EPO; JPO;<br>DERWEN<br>T;<br>IBM_TDB | 2006/09/13 17:29 |

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| 6  | BRS  | L6  | 38   | (prediction same metric) and ((time-varying) same parameters) | US-PGPUB;<br>USPAT;<br>USOCR;<br>FPRS;<br>EPO; JPO;<br>DERWEN<br>T;<br>IBM_TDB | 2006/09/13 17:18 |
| 7  | BRS  | L7  | 1    | (decomposing same (time-varying) same parameters)             | US-PGPUB;<br>USPAT;<br>USOCR;<br>FPRS;<br>EPO; JPO;<br>DERWEN<br>T;<br>IBM_TDB | 2006/09/13 17:18 |
| 8  | BRS  | L8  | 14   | decomposing same (time-varying)                               | US-PGPUB;<br>USPAT;<br>USOCR;<br>FPRS;<br>EPO; JPO;<br>DERWEN<br>T;<br>IBM_TDB | 2006/09/13 17:20 |
| 9  | BRS  | L9  | 2    | decomposing same (time-varying) same measur\$6                | US-PGPUB;<br>USPAT;<br>USOCR;<br>FPRS;<br>EPO; JPO;<br>DERWEN<br>T;<br>IBM_TDB | 2006/09/13 17:19 |
| 10 | BRS  | L10 | 59   | (time-varying) and (orthogonal same Fourier) and nonlinear    | US-PGPUB;<br>USPAT;<br>USOCR;<br>FPRS;<br>EPO; JPO;<br>DERWEN<br>T;<br>IBM_TDB | 2006/09/13 17:21 |

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| 2 | BRS  | L2  | 81   | (prediction same metric) and ((higher same level) same process)                               | US-PGPUB;<br>USPAT;<br>USOCR;<br>FPRS;<br>EPO; JPO;<br>DERWEN<br>T;<br>IBM_TDB | 2006/09/13 17:14 |
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